Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSII)

# 2SK3662

Switching Regulator, DC-DC Converter, Motor Drive Applications

- Low drain-source ON resistance:  $R_{DS}$  (ON) = 9.4 m $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 55 \text{ S} (typ.)$
- Low leakage current:  $I_{\rm DSS}$  = 100  $\mu A$  (max) (V\_{\rm DS} = 60 V)

Enhancement mode :  $V_{th} = 1.3$  to 2.5 V ( $V_{DS} = 10$  V,  $I_D = 1$  mA)

#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V <sub>DSS</sub>	60	V	
Drain-gate voltage (R	<sub>GS</sub> = 20 kΩ)	V <sub>DGR</sub>	60	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	I <sub>D</sub>	35	А	
	Pulse (Note 1)	I <sub>DP</sub>	105	~	
Drain power dissipation	on (Tc = 25°C)	PD	35	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	204	mJ	
Avalanche current		I <sub>AR</sub>	35	A	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	3.5	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	range	T <sub>stg</sub>	–55 to 150	°C	



Weight: 1.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch−c)</sub>	3.57	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch−a)</sub>	62.5	°C/ W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD} = 25 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$  (initial), L = 227  $\mu$ H, I<sub>AR</sub> = 35 A, R<sub>G</sub> = 25  $\Omega$ 

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

**Electrical Characteristics (Ta = 25°C)** 

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS}=\pm 16~V,~V_{DS}=0~V$	_		±10	μA
Drain cut-off curr	in cut-off current		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			100	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	60	_	_	v
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	40	_	_	
Gate threshold v	oltage	V <sub>th</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.3	—	2.5	V
Drain-source ON resistance		R <sub>DS (ON)</sub>	$V_{GS} = 4 V$ , ID = 18 A	_	12.5	19	mΩ
			$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 18 \text{ A}$	_	9.4	12.5	
Forward transfer	vard transfer admittance $ Y_{fs} $ $V_{DS} = 10 V$ , $I_D = 18 A$		$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 18 \text{ A}$	28	55	_	S
Input capacitance	Input capacitance			_	5120	_	pF
Reverse transfer	Reverse transfer capacitance		$V_{DS}$ = 10 V, $V_{GS}$ = 0 V, f = 1 MHz	_	300	_	
Output capacitance		C <sub>oss</sub>		_	500	_	
Switching time	Rise time	tr	$V_{GS}$ 0 V $I_D = 18 \text{ A}$ VOUT 0 V $GS$ 0 V	_	6		- ns
	Turn-on time	t <sub>on</sub>		_	19		
	Fall time	t <sub>f</sub>		_	20		
	Turn-off time	t <sub>off</sub>	V <sub>DD</sub> ≈ 30 V Duty ≤ 1%, t <sub>w</sub> = 10 μs	_	115	_	
Total gate charge (gate-source plus gate-drain)		Qg	V <sub>DD</sub> ≈ 48 V, V <sub>GS</sub> = 10 V,		91		nC
Gate-source charge		Q <sub>gs</sub>	$I_{\rm D} = 35 \rm{A}$		70	_	
Gate-drain ("mille	Gate-drain ("miller") charge			_	21	_	

### Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

Characteristics	S	ymbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Not	e 1)	I <sub>DR</sub>	—	_		35	А
Pulse drain reverse current (Not	e 1)	DRP	—		_	105	А
Forward voltage (diode)	V	DS2F	I <sub>DR1</sub> = 35 A, V <sub>GS</sub> = 0 V	_	_	-1.5	V
Reverse recovery time		t <sub>rr</sub>	$I_{DR} = 35 \text{ A}, \text{ V}_{GS} = 0 \text{ V},$	_	60		ns
Reverse recovery charge		Q <sub>rr</sub>	dI <sub>DR</sub> /dt = 50 A/µs	_	58	_	nC

### Marking



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Gate threshold voltage V<sub>th</sub> (V)

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 $R_G = 25 \Omega$ 

Waveform  $E_{AS} = \frac{1}{2} \cdot L \cdot l^2 \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$  $V_{DD} = 25 \text{ V}, \text{ L} = 227 \ \mu\text{H}$ 

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